

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/779,712	FUJITA ET AL.	
Examiner		Art Unit	Page 1 of 1	
Wen-Ying P. Chen		2871		

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2002/0113936	08-2002	Yanagawa et al.	349/155
B	US-5,576,859	11-1996	Castleberry, Donald	349/110
C	US-6,275,280	08-2001	Kajita et al.	349/155
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 2002341329 A	11-2002	Japan	OTA et al.	G02F 01/1335
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U		
V		
W		
X		

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